

Notice of References Cited	Application/Control No. 10/632,809	Applicant(s)/Patent Under Reexamination KIYONO ET AL.	
	Examiner Jianchun Qin	Art Unit 2837	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2004/0014513	01-2004	Boon, Edward J.	463/8
*	B	US-2004/0083873	05-2004	Yoshino et al.	084/107
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FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

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